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Fault Detection and Localization Using Electromagnetic Sensors

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Message from the Guest Editors

A Special Issue (SI) under the title "Fault Detection and Localization using Electromagnetic Sensors" is proposed to address the ever present and increasing societal needs for accurate detection, localization and characterization of faults within engineered components, processes and systems. This is to avoid the loss of monetary value, ensure safety and reduce wastage as well as to facilitate precise monitoring, diagnosis, and therapy of biological processes associated with human health and wellbeing in order to avoid onset and enable prevention and early treatment of illnesses.













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Message from the Editor-in-Chief

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